

Attorney Docket No.: SON-2769

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Patent Application of

Hidetoshi OHNUMA, et al

Group: 1756

Serial No. 10/603,689

Examiner: Daborah Chacko Davis

Filed: June 26, 2003

Confirmation No. 2872

For: EXPOSURE METHOD, MASK

FABRICATION METHOD, FABRICATION METHOD OF SEMICONDUCTOR DEVICE

AND EXPOSURE APPARATUS

INFORMATION DISCLOSURE STATEMENT (IDS)

MS Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Pursuant to 37 CFR 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the reference listed on the attached PTO/SB/08. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is filed more than three months after the U.S. filing date, AND after the mailing date of the first Office Action on the merits, but before the mailing date of a Final Office Action or Notice of Allowance (37 CFR 1.97(c)).

A copy of the reference on the PTO/SB/08 is attached 5715/2006 SZEWDIE1 00000172 180013

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In accordance with 37 CFR 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made or that no other material Application No.: 10/603,689 Docket No.: SON-2769

information as defined in 37 CFR 1.56(a) exists. In accordance with 37 CFR 1.97(h), the filing of this Information Disclosure statement shall not be construed to be an admission that any patent, publication or other information referred to therein is "prior art" for this invention unless specifically designated as such.

It is submitted that the Information Disclosure Statement is in compliance with 37 CFR 1.98 and the Examiner is respectfully requested to consider the listed references.

Please charge our Deposit Account No. 18-0013 in the amount of \$180.00 covering the fee set forth in 37 CFR 1.17(p). The Director is hereby authorized to charge any deficiency in the fees filed, asserted to be filed or which should have been filed herewith (or with any paper hereafter filed in this application by this firm) to our Deposit Account No. 18-0013, under Order No. SON-2769. A duplicate copy of this paper is enclosed.

Dated: May 12, 2006

Respectfully submitted,

By Ronald P. Kananen

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PTO/SB/08a/b (08-03)

Approved for use through 07/31/2006. OMB 0651-0031

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Substitute for form 1449A/B/PTO				Complete if Known		
				Application Number	10/603,689	
11	IFORMATION	I DI	SCLOSURE	Filing Date	June 26, 2003	
STATEMENT BY APPLICANT (Use as many sheets as necessary)				First Named Inventor	Hidetoshi Ohnuma	
				Art Unit	1756	
				Examiner Name	Daborah Chacko Davis	
Sheet	1	of	1	Attorney Docket Number	SON-2769	

U.S. PATENT DOCUMENTS						
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where	
Initials*	No.1	Number-Kind Code ² (if known)	MM-DD-YYYY	Applicant of Cited Document	Relevant Passages or Relevant Figures Appear	
	AA	US 2001-0055733	12/27/2001	Nobuyuki Ire, et al		
	AB					
	AC					

	FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
	ВА					П		
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	CA	International Search Report mailed February 1, 2005			
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